

110V, 199A, 2.3mΩ N-channel Power SGT MOSFET

JMSH1102TE

Features

- $\bullet \;\;$ Excellent $R_{DS(ON)}$ and Low Gate Charge
- 100% UIS TESTED
- 100% ΔVds TESTED
- Halogen-free; RoHS-compliant
- Pb-free plating

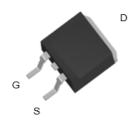
Applications

- Load Switch
- PWM Application
- Power Management

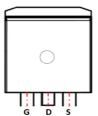
Product Summary

Parameters	Value	Unit
V_{DSS}	110	V
$V_{GS(th)_Typ}$	3.0	V
$I_D(@V_{GS}=10V)$	199	Α
$R_{DS(ON)_Typ}(@V_{GS}=10V$	2.3	mΩ

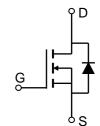








Pin Assignment



Schematic Diagram

Ordering Information

Device	Marking	MSL	Form	Package	Reel(pcs)	Per Carton (pcs)
JMSH1102TE	SH1102T	3	Tape&Reel	TO-263-3L	800	4000

Absolute Maximum Ratings (@ T_C = 25°C unless otherwise specified)

Symbol	Parameter		Value	Unit	
V_{DS}	Drain-to-Source Voltage		110	V	
V_{GS}	Gate-to-Source Voltage		±20	V	
	Continuous Drain Current	$T_C = 25^{\circ}C$	199	^	
I _D	Continuous Drain Current	$T_C = 100$ °C	126	A	
I _{DM}	Pulsed Drain Current (1)		Refer to Fig.4	Α	
E _{AS}	Single Pulsed Avalanche Energy (2)		1384	mJ	
P_{D}	Dower Dissipation	$T_C = 25^{\circ}C$	250	W	
LD	Power Dissipation	$T_C = 100$ °C	100	VV	
T_{J} , T_{STG}	Junction & Storage Temperature Range		-55 to 150	°C	

Thermal Characteristics

Symbol Parameter		Max	Unit
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient ⁽³⁾	32	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.5	C/VV



Electrical Characteristics (T_J = 25°C unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Cha	racteristics					
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	110	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 88V, V_{GS} = 0V$	-	-	1.0	μА
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Cha	racteristics	•				
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.1	3.0	3.9	V
R _{DS(ON)}	Static Drain-Source ON-Resistance ⁽⁴⁾	$V_{GS} = 10V, I_D = 20A$	-	2.3	3.3	mΩ
Dynami	ic Characteristics					
R_{g}	Gate Resistance	f = 1MHz	-	2.6	-	Ω
C _{iss}	Input Capacitance		6778	9489	12810	pF
C _{oss}	Output Capacitance	$V_{GS} = 0V$, $V_{DS} = 55V$, $f = 1MHz$	1056	1479	1997	pF
C _{rss}	Reverse Transfer Capacitance	1 - 11/11/12	22	31	42	pF
Qg	Total Gate Charge		95	133	179	nC
Q_{gs}	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 55V, I_{D} = 20A$	33	46	63	nC
Q_{gd}	Gate Drain("Miller") Charge	V DS = 33 V, ID = 20/1	19	27	36	nC
0 1/ 1 1						
	ng Characteristics	1			1	
t _{d(on)}	Turn-On DelayTime	_	-	40	-	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 55V$	-	59	-	ns
$t_{d(off)}$	Turn-Off DelayTime	I_{D} = 20A, R_{GEN} = 6.2 Ω	-	110	-	ns
t _f	Turn-Off Fall Time		-	64	-	ns
Body D	iode Characteristics				T	
I _S	Maximum Continuous Body Diode Forward Current		-	-	199	Α
I _{SM}	Maximum Pulsed Body Diode Forward Current		-	-	796	Α
V_{SD}	Body Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 20A$	-		1.2	V
trr	Body Diode Reverse Recovery Time	I _F = 20A, di/dt = 100A/us	68	95	129	ns
Qrr	Body Diode Reverse Recovery Charge	$\int_{0}^{\infty} f = 20A$, $\frac{d}{dt} = 100A$ / $\frac{dt}{dt} = 100A$	-	306	-	nC

Notes:

^{1.} Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

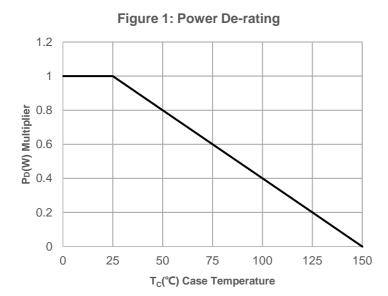
 $^{2.\;}E_{AS}\;condition:\;Starting\;T_J=25C,\;V_{DD}=55V,\;V_G=10V,\;R_G=25ohm,\;L=3mH,\;I_{AS}=30.38A,\;V_{DD}=0V\;during\;time\;in\;avalanche.$

^{3.} $R_{\theta JA}$ is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB.

^{4.} Pulse Test: Pulse Width $\!\!\!\!<\!300\mu s,$ Duty Cycle $\!\!\!<\!0.5\%.$



Typical Performance Characteristics



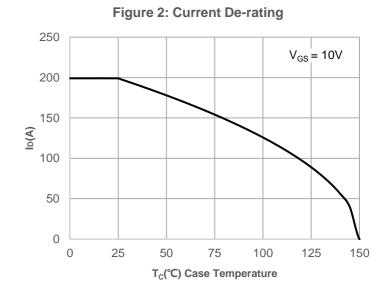
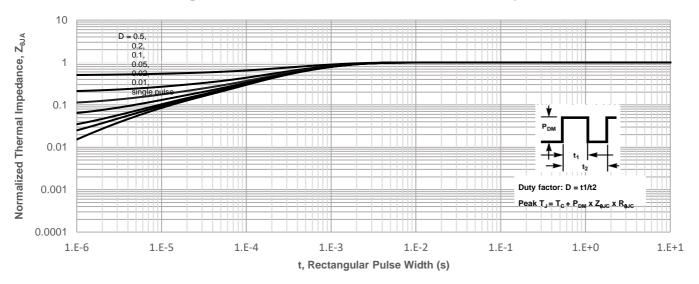
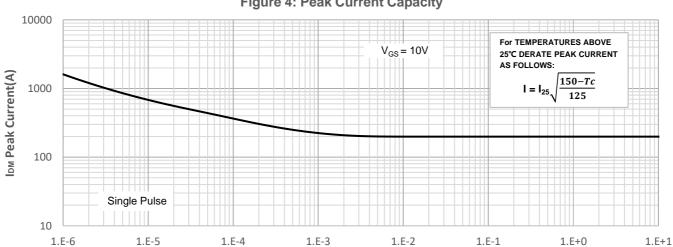


Figure 3: Normalized Maximum Transient Thermal Impedance





t, Rectangular Pulse Width (s)



Typical Performance Characteristics

Figure 5: Output Characteristics

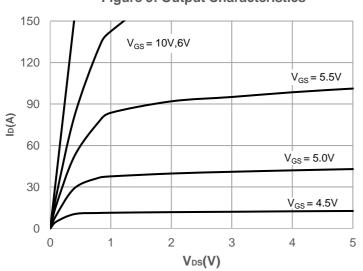


Figure 6: Typical Transfer Characteristics

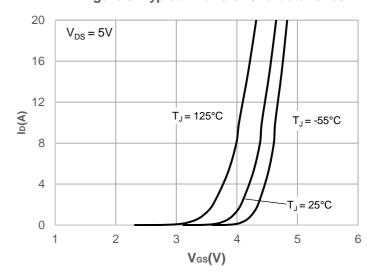


Figure 7: On-resistance vs. Drain Current

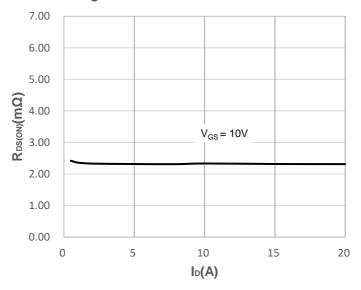


Figure 8: Body Diode Characteristics

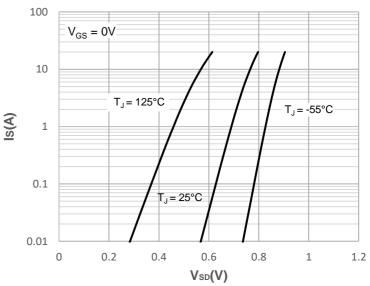


Figure 9: Gate Charge Characteristics

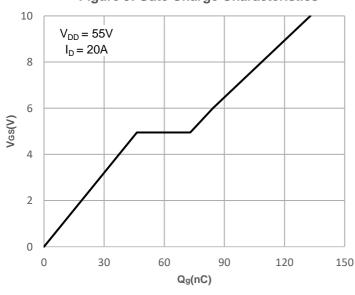
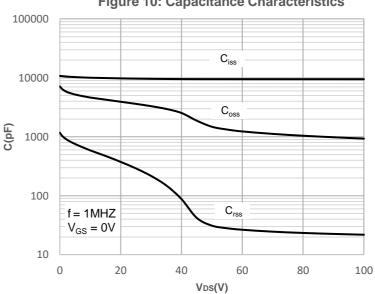


Figure 10: Capacitance Characteristics





Typical Performance Characteristics

Figure 11: Normalized Breakdown voltage vs. Junction Temperature

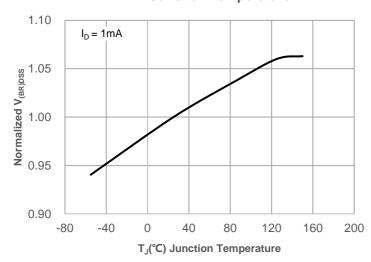


Figure 13: Normalized Threshold Voltage vs. Junction Temperature

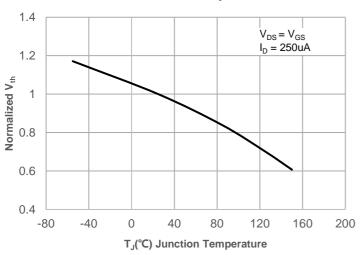


Figure 15: Maximum Safe Operating Area

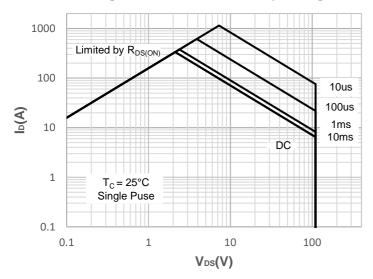
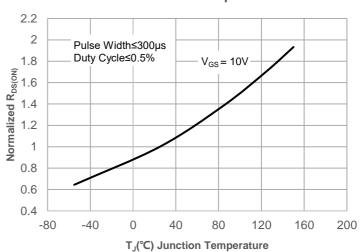
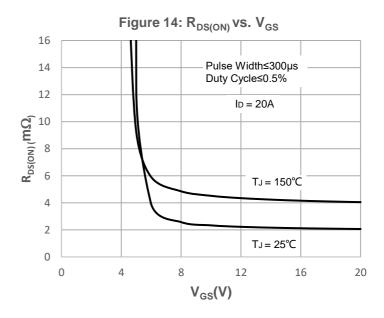


Figure 12: Normalized on Resistance vs. Junction Temperature







Test Circuit

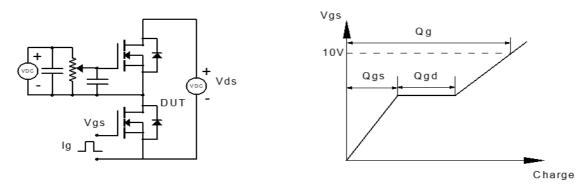


Figure 1: Gate Charge Test Circuit & Waveform

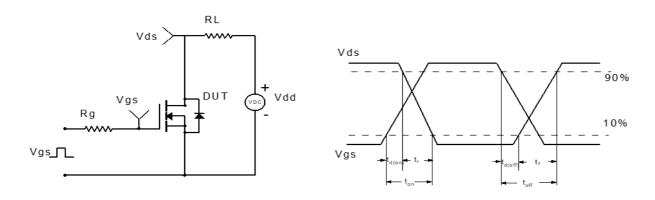


Figure 2: Resistive Switching Test Circuit & Waveform

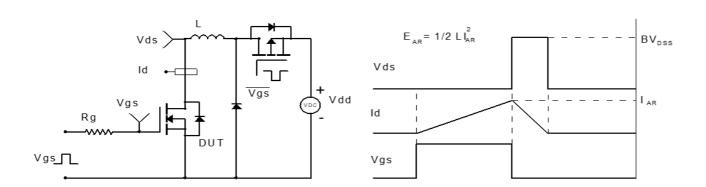


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

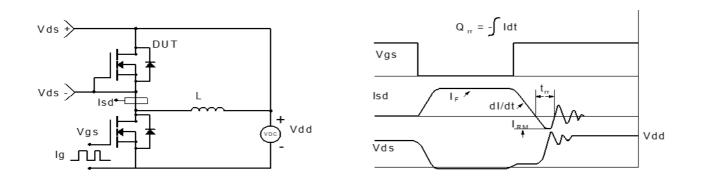
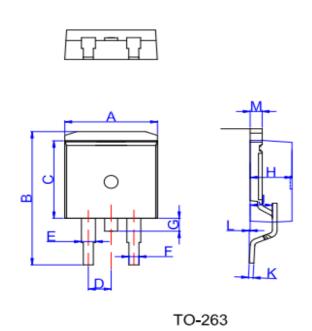


Figure 4: Diode Recovery Test Circuit & Waveform

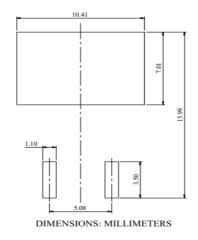


Package Mechanical Data(TO-263-3L)



			Dime	nsions		
Ref.	Millimeters			Inches		
	Min.	Тур.	Max.	Min.	Тур.	Max.
Α	9.90		10.20	0.390		0.402
В	14.70		15.80	0.579		0.622
С	9.4		9.6	0.37		0.378
D		2.54			0.100	
E	1.20		1.40	0.047		0.055
F	0.75		0.85	0.029		0.033
G			1.75			0.069
Н	4.40		4.70	0.173		0.185
J	2.30		2.70	0.091		0.106
K	0.38		0.55	0.015		0.022
L	0	0.10	0.25	0	0.004	0.010
М	1.25		1.35	0.049		0.053

Recommended Footprint



Information furnished in this document is believed to be accurate and reliable. However, Jiangsu JieJie Microelectronics Co., Ltd assumes no responsibility for the consequences of use without consideration for such information nor use beyond it. Information mentioned in this document is subject to change without notice, apart from that when an agreement is signed, Jiangsu JieJie complies with the agreement. Products and information provided in this document have no infringement of patents. Jiangsu JieJie assumes no responsibility for any infringement of other rights of third parties which may result from the use of such products and information.

is a registered trademark of Jiangsu JieJie Microelectronics Co.,Ltd.